



RADIO TEST REPORT

Test Report No.: 31IE0189-SH-01-A

Applicant : Sony Corporation
Type of Equipment : Bluetooth Module
Model No. : A-1833-832-A
FCC ID : AK8A1833832
Test regulation : FCC Part15 Subpart C: 2010
Test result : Complied

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Date of test: April 25 to May 12, 2011

Representative test engineer:

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13-EM-F0429

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SECTION 1: Customer information

Company Name : Sony Corporation
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Japan
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Contact Person : Shigeru Higai

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Bluetooth Module
Model Number : A-1833-832-A
Serial Number : Refer to clause 4.2
Rating : DC3.3V
Country of Mass-production : Japan
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Receipt Date of Sample : April 25, 2011
Modification of EUT : No modification by the test lab.

2.2 Product description

Model: A-1833-832-A (referred to as the EUT in this report) is a Bluetooth Module.

Clock frequency(ies) in the system : 24MHz

<Radio part>

Equipment type : Transceiver
Frequency of operation : 2402-2480MHz
Bandwidth / Channel spacing : 79MHz & 1MHz
Type of modulation : FHSS (GFSK, $\pi/4$ -DQPSK, 8DPSK)
Antenna type : Chip Helical Antenna
Antenna connector type : None
Antenna gain : 2.2dBi
ITU code : F1D, G1D
Operation temperature range : -40 to 85 deg.C

The A-1833-832-A has derived model, A-1833-833-A.

Both differences are types of the connector and methods of the audio output.

	A-1833-832-A	A-1833-833A
Connector	14pin	13pin
Audio output	Analog	Digital

FCC Part15.31 (e)

The Bluetooth Module is provided with stable power supply DC 3.3V from the host device, therefore, the equipment complies with power supply regulation.

FCC Part15.203 Antenna requirement

It is impossible for end users to replace the antenna, because it is soldered on the circuit board. Therefore the equipment complies with the requirement of 15.203/212.

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SECTION 3: Test specification, procedures & results

3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2010, final revised on December 6, 2010 and effective January 5, 2011
Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.209 Radiated emission limits, general requirements
Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz

* The EUT complies with FCC Part 15 Subpart B: 2010, final revised on December 6, 2010 and effective January 5, 2011.

3.2 Procedures & Results

Item	Test Procedure	Specification	Remarks	Deviation	Worst Margin	Results
Conducted emission	ANSI C63.4:2003 7. AC powerline conducted emission measurements	FCC Section 15.207	-	N/A	8.6dB Freq.: 0.41098MHz Detector: QP Phase: N	Complied
Carrier frequency separation	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)	Conducted	N/A	*See data.	Complied
20dB bandwidth	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)	Conducted	N/A		-
Number of hopping frequency	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)(iii)	Conducted	N/A		Complied
Dwell time	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)(iii)	Conducted	N/A		Complied
Maximum peak output power	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (b)(1)	Conducted	N/A		Complied
Band edge compliance & Spurious emission	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (d) Section15.209	Conducted/ Radiated	N/A		7.9dB Freq.: 1602.02MHz Detector: Average Polarization: Horizontal Mode: Tx 2402MHz, 3-DH5

Note: UL Japan's Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

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3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results
Occupied Bandwidth (99%)	ANSI C63.4:2003 13. Measurement of intentional radiators, RSS-Gen 4.6.1	RSS-Gen 4.6.1	Conducted	-	-

Note: UL Japan's EMI Work Procedures No.13-EM-W0420 and 13-EM-W0422.

* Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC ^{*1} /SR ^{*2} (±)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Conducted emission (AC Mains) AMN/LISN	150kHz-30MHz	3.0 dB	2.7 dB	3.1 dB
Radiated emission (Measurement distance: 3m)	30MHz-300MHz	4.7 dB	4.5 dB	4.7 dB
	300MHz-1GHz	4.5 dB	4.6 dB	4.6 dB
	1GHz-13GHz	3.9 dB	3.9 dB	4.0 dB
Radiated emission (Measurement distance: 1m)	13GHz-18GHz	4.8 dB	4.8 dB	4.8 dB
	18GHz-40GHz	4.4 dB	4.2 dB	4.2 dB

*1: SAC=Semi-Anechoic Chamber

*2: SR= Shielded Room is applied besides radiated emission

*3: Value of Antenna Terminal Voltage measurement is also applies to the No.5 and No.6 Shielded Room.

Conducted emission test

The data listed in this test report has enough margin, more than site margin.

Radiated emission test

The data listed in this test report has enough margin, more than site margin.

Antenna port conducted test

Power Measurement uncertainty above 1GHz for this test was: (±) 1.3dB

Conducted emissions Measurement (below 1GHz) uncertainty for this test was: (±) 1.9dB

Conducted emissions Measurement (1G-3GHz) uncertainty for this test was: (±) 2.5dB

Conducted emissions Measurement (3G-18GHz) uncertainty for this test was: (±) 3.8dB

Conducted emissions Measurement (18G-26.5GHz) uncertainty for this test was: (±) 4.1dB

Bandwidth Measurement uncertainty for this test was: (±) 5.4%

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3.5 Test location

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JAB Accreditation No. : RTL02610

	FCC Registration No.	IC Registration No.	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
<input checked="" type="checkbox"/> No.1 Semi-anechoic chamber	697847	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
<input checked="" type="checkbox"/> No.2 Semi-anechoic chamber	697847	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
<input type="checkbox"/> No.3 Semi-anechoic chamber	697847	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5m
<input type="checkbox"/> No.4 Full-anechoic chamber	-	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
<input checked="" type="checkbox"/> No.1 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
<input type="checkbox"/> No.2 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
<input type="checkbox"/> No.3 shielded room	-	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
<input type="checkbox"/> No.4 shielded room	-	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
<input checked="" type="checkbox"/> No.5 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
<input type="checkbox"/> No.6 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-

3.6 Test setup, Data of test & Test instruments

Refer to Appendix 1 to 3.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating mode

The EUT exercise program used during testing was designed to exercise the various system components in a manner similar to typical use.

Test item	Operating mode	Tested frequency
Carrier frequency separation	Transmitting Hopping ON (DH5/3DH5)/Inquiry, Payload: PRBS9	-
20dB bandwidth	Transmitting Hopping OFF (DH5/3DH5)/Inquiry, Payload: PRBS9	2402MHz, 2441MHz, 2480MHz
Number of hopping frequency	Transmitting Hopping ON (DH5/3DH5)/Inquiry, Payload: PRBS9	-
Dwell time	Transmitting (Hopping ON), Payload: PRBS9 -DH1, -DH3, -DH5 -3DH1, -3DH3, -3DH5 -Inquiry	-
Maximum peak output power	Transmitting (Hopping OFF), Payload: PRBS9 -DH5, -2DH5, -3DH5	2402MHz, 2441MHz, 2480MHz
Band edge compliance & Spurious emission (Conducted)	Transmitting (DH5/3DH5), Payload: PRBS9 -Hopping ON -Hopping OFF	Band edge compliance: 2402MHz, 2480MHz
(Radiated)	Transmitting (DH5/3DH5), Payload: PRBS9	Spurious emission: 2402MHz, 2441MHz, 2480MHz
99% occupied bandwidth	Transmitting (DH5/3DH5), Payload: PRBS9 -Hopping ON -Hopping OFF	2402MHz, 2441MHz, 2480MHz

*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload (except Dwell time test).

*Remarks: Test was not performed at AFH mode, because the decrease of number of channel (min: 20ch) at AFH mode does not influence on the output power and bandwidth of the EUT. However, the limit level 125mWof AFH mode was used for the test.

*EUT has the power settings by the software as follows;

Power settings: BDR: Ext=255 Int=44,
EDR: Ext=255 Int=48

Software: CSR Blue Test

Software Version: Release Build 3

Justification: The system was configured in typical fashion (as customer would normally use it) for testing.

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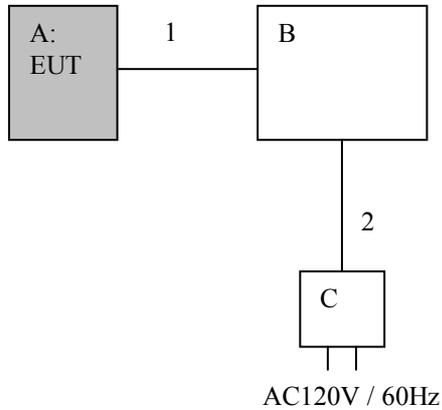
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4.2 Configuration of tested system



* Test data was taken under worse case conditions.

Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Bluetooth Module	A-1833-832-A	71	Sony	EUT
B	Jig board	BT-JIG	-	Sony	-
C	AC Adaptor	AC-E5212	B401080	Sony	-

List of cables used *1)

No.	Item	Length(m)	Shield		Remarks
			Cable	Connector	
1	DC and Signal	0.2	Unshielded	Unshielded	-
2	DC	1.9	Unshielded	Unshielded	-

*1) All cables used for the measurement are exclusive use or marketed.

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SECTION 5: Conducted emission

5.1 Operating environment

The test was carried out in No.1 shielded room.

Temperature : See test data
Humidity : See test data

5.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT was aligned and was flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from LISN. They were folded back and for the forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. Photographs of the set up are shown in Appendix 1.

5.3 Test conditions

Frequency range : 0.15 - 30MHz
EUT position : Table top

5.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT via host device within a screened room. The host device was connected to a Line Impedance Stabilization Network (LISN). An overview sweep with peak detection has been performed. The measurements had been performed with a quasi-peak detector and if required, an average detector. The conducted emission measurements were made with the following detector of the test receiver.

Detector Type : Quasi-Peak / Average
IF Bandwidth : 9kHz

5.5 Results

Summary of the test results : Pass

SECTION 6: Carrier frequency separation

Test procedure

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 7: 20dB bandwidth & Occupied bandwidth (99%)

Test procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

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SECTION 8: Number of hopping frequency

Test procedure

The Number of Hopping Frequency was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 9: Dwell time

Test procedure

The Dwell time was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 10: Maximum peak output power

Test procedure

The Maximum Peak Output Power was measured with a power meter connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 11: Spurious emissions (Antenna port conducted)

Test procedure

The Out of Band Emissions was measured with a spectrum analyzer connected to the antenna port.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.
(9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=10kHz)

Summary of the test results: Pass
Refer to APPENDIX 2

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SECTION 12: Radiated emission

12.1 Operating environment

The test was carried out in No.1 and No.2 Semi-Anechoic Chamber.

Temperature : See test data (APPENDIX 2)
Humidity : See test data (APPENDIX 2)

12.2 Test configuration

EUT was placed on a platform of nominal size, 0.5m by 0.5m, raised 80cm above the conducting ground plane. The table is made of Styrofoam. That has very low permittivity.

The rear of EUT, including its peripherals was aligned and flushed with rear of tabletop. I/O cables that were connected to the peripherals were bundled in center. They were folded back and for the forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

Photographs of the set up are shown in Appendix 1.

12.3 Test conditions

Frequency range : 30MHz to 25GHz
Test distance : 3m (below 13GHz) / 1m (above 13GHz)
EUT position : Table top

12.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi-anechoic chamber with a ground plane and at a distance of 3m (below 13GHz) / 1m (above 13GHz). Measurements were performed with quasi-peak, peak and average detector. The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detection of the test receiver and Spectrum Analyzer.

Frequency	:	30-1000MHz	1000-25000MHz	
Detection Type	:	Quasi-Peak	Peak	* Average
IF Bandwidth	:	120kHz	RBW:1MHz/VBW:3MHz	RBW:1MHz/VBW:See data

* When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

* The VBW was based on the inverse of the duty cycle (Refer to Appendix 2).

The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Worst position:

	Horizontal	Vertical
Below 1GHz	X	X
Above 1GHz(Carrier)	X	Z
Above 1GHz(Sprious)	See comment of the data	See comment of the data

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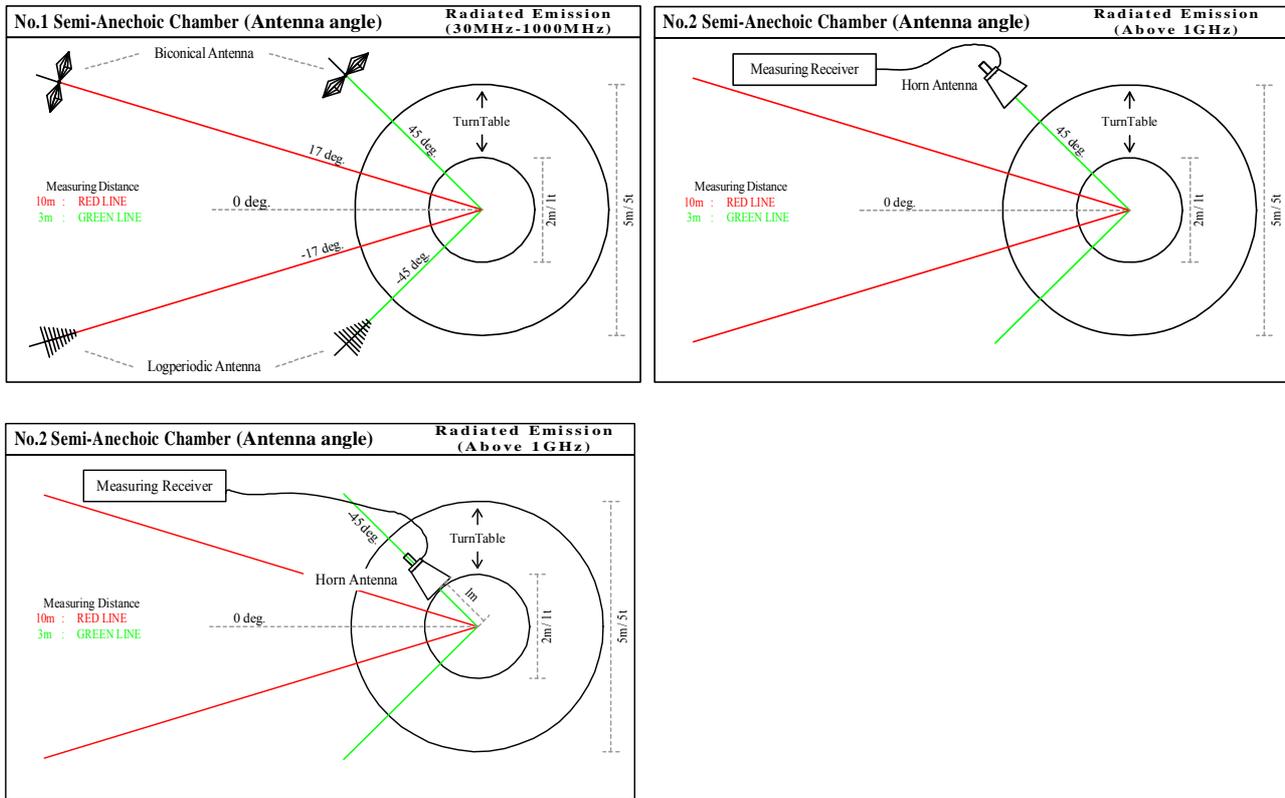
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Figure 1. Antenna angle



12.5 Band edge

Band edge level at 2399.5MHz, 2399.642MHz and 2400MHz are less than 20dB of peak point of the carrier. Band edge level at 2390MHz and 2483.5MHz is below the limits of FCC 15.209. Refer to the data of Radiated emission.

12.6 Results

Summary of the test results : Pass *No noise was detected above the 5th order harmonics.
Refer to APPENDIX 2

Contents of appendixes

APPENDIX 1: Photographs of test setup

Conducted emission
Radiated emission
Pre-check of the worst position

APPENDIX 2: Test data

Conducted emission
20dB bandwidth and Carrier frequency separation
Number of hopping frequency
Dwell time
Maximum peak output power
Spurious emission (Antenna port conducted)
Radiated emission
99% Occupied bandwidth

APPENDIX 3: Test instruments

Test instruments

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